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- Inputs Are TTL-Voltage Compatible
- Provide Bus Interface From Multiple Sources in High-Performance Systems
- High-Current 3-State Outputs Interface Directly With System Bus
- Buffered Inputs and Outputs
- Package Options Include Ceramic Chip Carriers (FK) and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

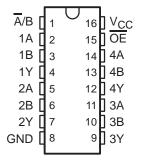
The 'HCT257 are designed to multiplex signals from 4-bit data sources to 4-output data lines in bus-organized systems. The 3-state outputs do not load the data lines when the output-enable (\overline{OE}) input is at the high logic level.

The SN54HCT257 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HCT257 is characterized for operation from –40°C to 85°C.

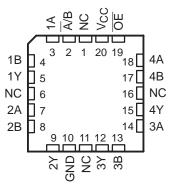
FUNCTION TABLE

	INPU			
	SELECT	DA	ATA	OUTPUT Y
OE	Ā/B	Α	В	·
Н	Х	Х	Χ	Z
L	L	L	X	L
L	L	Н	X	Н
L	Н	Х	L	L
L	Н	Х	Н	Н

SN54HCT257 . . . J PACKAGE SN74HCT257 . . . N PACKAGE (TOP VIEW)



SN54HCT257 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

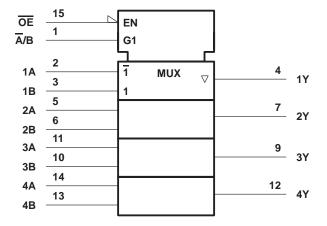


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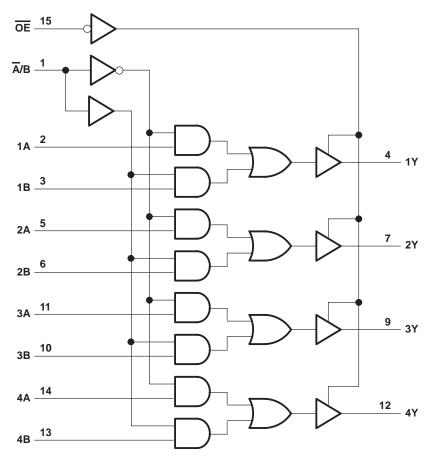
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logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the J and N packages.

logic diagram (positive logic)



Pin numbers shown are for the J and N packages.



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absolute maximum ratings over operating free-air temperature range†

Supply voltage range, V _{CC}	$-0.5~V$ to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	$\dots \dots \pm 20 \ mA$
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	$\dots \dots \pm 20 \ mA$
Continuous output current, I_O ($V_O = 0$ to V_{CC})	$\dots \dots \pm 35 \text{ mA}$
Continuous current through V _{CC} or GND	$\dots \dots \pm 70 \; mA$
Package thermal impedance, θ_{JA} (see Note 2): N package	78°C/W
Storage temperature range, T _{sto}	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

				SN54HCT257			SN74HCT257		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	V _{CC} = 4.5 V to 5.5 V	2	į.	,	2			V
VIL	Low-level input voltage	V _{CC} = 4.5 V to 5.5 V	0	75	0.8	0		0.8	V
VI	Input voltage		0	5	VCC	0		VCC	V
Vo	Output voltage		0	2	VCC	0		VCC	V
t _t	Input transition (rise and fall) time		9 0)"	500	0		500	ns
TA	Operating free-air temperature		-55		125	-40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V	T _A = 25°C			SN54HCT257		SN74HCT257		UNIT
PARAMETER			VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
Voн	VI = VIH or VIL	$I_{OH} = -20 \mu A$	4.5 V	4.4	4.499		4.4		4.4		V
VOH	AI = AIH OL AIL	$I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
Vol	\/ \/ or \/	$I_{OL} = 20 \mu A$	4.5 V		0.001	0.1		0.1		0.1	V
VOL	VI = VIH or VIL	$I_{OL} = 6 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	v
lį	$V_I = V_{CC}$ or 0		5.5 V		±0.1	±100		±1000		±1000	nA
loz	$V_O = V_{CC}$ or 0,	$V_I = V_{IH} \text{ or } V_{IL}$	5.5 V		±0.01	±0.5	4:	±10		±5	μΑ
Icc	$V_I = V_{CC}$ or 0,	I _O = 0	5.5 V			8	37/	160		80	μΑ
Δl _{CC} ‡	One input at 0.5 V Other inputs at 0 or		5.5 V		1.4	2.4	Oyy	3		2.9	mA
Ci			4.5 V to 5.5 V	·	3	10		10*		10	pF

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.



^{2.} The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

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switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	T/	λ = 25°C	;	SN54H	CT257	SN74H	CT257	UNIT			
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT			
	A or B	Y	4.5 V		20	30		45		38				
	AOIB	ı	5.5 V		17	27		40		34	ne			
^t pd	Ā/B	Y	4.5 V		20	30		45		38	ns			
	A/B	Ť	ı	5.5 V		17	27		40		34			
	ŌĒ				Y	4.5 V		20	30	. 4	45		38	20
t _{en}		Ť	ı	5.5 V		17	27	(2)	40		34	ns		
+	<u></u>	Y	4.5 V		20	30	$g_{Q_{\zeta}}$	45		38	20			
^t dis	ŌĒ		5.5 V		17	27	N.	40		34	ns			
t _t		Any	4.5 V		8	15		22		19	no			
		Any	5.5 V		7	14		21		17	ns			

switching characteristics over recommended operating free-air temperature range, C_L = 150 pF (unless otherwise noted) (see Figure 1)

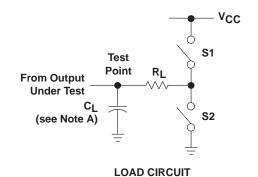
PARAMETER	FROM TO		Vaa	T,	ղ = 25°C	;	SN54HC	T257	SN74H	CT257	UNIT		
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT		
	A or B		4.5 V		22	38		57		48			
.	AOIB	Y	5.5 V		19	35		53		44	ns		
^t pd	Ā/B	Y	4.5 V		22	38		4 /57		48	115		
			5.5 V		19	35	1	53		44			
	ŌĒ		. o v	V	4.5 V		23	40	0/2	60		50	no
^t en		l f	ı	5.5 V		20	38	20	57		48	ns	
t _t	Any	Any	4.5 V		17	42	Q	63		53	no		
		Ally	5.5 V		14	38		57		48	ns		

operating characteristics, T_A = 25°C

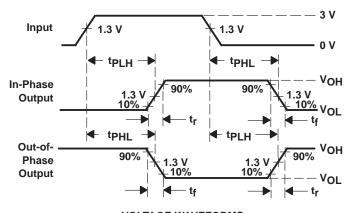
	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load	13	pF

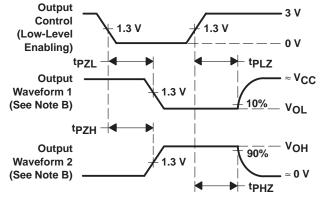
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PARAMETER MEASUREMENT INFORMATION



PARA	PARAMETER		CL	S1	S2	
	tPZH	1 k Ω	50 pF	Open	Closed	
чen	t_{en} t_{PZL} $1 k\Omega$ or t_{PZL} $150 pF$		Closed	Open		
.	tPHZ	1 k Ω	50 pF	Open	Closed	
^t dis	tPLZ	1 K22	30 pr	Closed	Open	
t _{pd} or	t _t		50 pF or 150 pF	Open	Open	





VOLTAGE WAVEFORMS
OUTPUT AND 3-STATE BIDIRECTIONAL I/O
PROPAGATION DELAY TIME

VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS

NOTES: A. C_L includes probe and test-fixture capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_{\Omega} = 50 \Omega$, $t_{r} = 6 \text{ ns}$, $t_{f} = 6 \text{ ns}$.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

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